SCAS052A - JULY 1987 - REVISED APRIL 1993

 Bidirectional Bus Transceivers in	DW OR NT PACKAGE			
High-Density 24-Pin Packages	(TOP VIEW)			
 Flow-Through Architecture Optimizes PCB	A1 [1 24] DIR			
Layout	A2 [2 23] B1			
 Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise 	A3 [] 3 22 [] B2 A4 [] 4 21 [] B3			
 EPIC ™ (Enhanced-Performance Implanted	GND [5 20] B4			
CMOS) 1-µm Process	GND [6 19] V _{CC}			
 500-mA Typical Latch-Up Immunity at	GND [] 7 18 [] V _{CC}			
125°C	GND [] 8 17 [] B5			
 Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs 	A5 9 16 B6 A6 10 15 B7 A7 11 14 B8 A8 12 13 OE			

description

These octal bus transceivers are designed for asynchronous communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus depending upon the level at the direction-control (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so that the buses are effectively isolated.

The 74AC11640 is characterized for operation from −40°C to 85°C.

FUNCTION TABLE

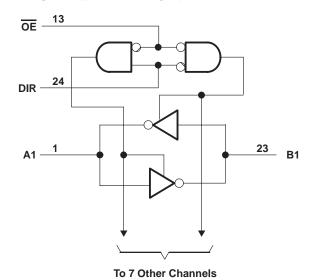
INP	UTS	OPERATION
OE	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	X	Isolation

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logic symbol†

13 OE G3 DIR 3 EN1 [BA] 3 EN2 [AB] 23 **B**1 1 2 ▽ 1 22 **B2 A2** 21 **A3 B3** 20 В4 Α4 17 Α5 **B5** 16 **B6** A6 15 11 **B7** Α7 14 12 **A8 B8**

logic diagram (positive logic)



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC} –0.5 V to 7	7 V
Input voltage range, V _I (see Note 1)	5 V
Output voltage range, V _O (see Note 1)	5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	mΑ
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	mΑ
Continuous output current, I_O ($V_O = 0$ to V_{CC}) ± 50 r	mΑ
Continuous current through V _{CC} or GND pins ±200 r	mΑ
Storage temperature range –65°C to 150	Э°С

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		3	5	5.5	V
	-	V _{CC} = 3 V	2.1			
V_{IH}		$V_{CC} = 4.5 \text{ V}$	3.15			V
		$V_{CC} = 5.5 V$	3.85			
		V _{CC} = 3 V			0.9	
VIL	Low-level input voltage	$V_{CC} = 4.5 \text{ V}$			1.35	V
		$V_{CC} = 5.5 V$			1.65	
٧ _I	Input voltage		0		VCC	V
VO	Output voltage		0		VCC	V
		V _{CC} = 3 V			-4	
ЮН	High-level output current	V _{CC} = 4.5 V			-24	mA
		V _{CC} = 5.5 V			-24	
		V _{CC} = 3 V			12	
l _{OL}	Low-level output current	$V_{CC} = 4.5 \text{ V}$			24	mA
		V _{CC} = 5.5 V			24	
Δt/Δν	Input transition rise or fell rate	OE or DIR	0		5	ns/V
ΔυΔν	Input transition rise or fall rate	Data	0		10	115/V
T _A	Operating free-air temperature	-	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	IVIIIV	WAX	UNIT
		3 V	2.9			2.9		
	$I_{OH} = -50 \mu\text{A}$	4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
VOН	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		V
		4.5 V	3.94			3.8		
	$I_{OH} = -24 \text{ mA}$	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	Ι _{ΟL} = 50 μΑ	3 V			0.1		0.1	
		4.5 V			0.1		0.1	
		5.5 V			0.1		0.1	
V _{OL}	I _{OL} = 12 mA	3 V			0.36		0.44	V
		4.5 V			0.36		0.44	
	I _{OL} = 24 mA	5.5 V			0.36		0.44	
	I _{OL} = 75 mA [†]	5.5 V					1.65	
I _I OE or DIR	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
I _{OZ} ‡ A or B ports	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μΑ
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
C _i OE or DIR	V _I = V _{CC} or GND	5 V		4				pF
C _{io}	$V_O = V_{CC}$ or GND	5 V		12				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
t _{PLH}	A or B	B or A	1.5	7	10.5	1.5	12	ns
^t PHL			1.5	6.3	9.1	1.5	10.2	
^t PZH	OE	A or B	1.5	8.9	12.5	1.5	14.3	ns
t _{PZL}			1.5	8.4	12.9	1.5	14.6	115
^t PHZ	OE	OE A or B	1.5	7.9	10	1.5	10.8	ne
t _{PLZ}	OE	AUD	1.5	8.6	11	1.5	12	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

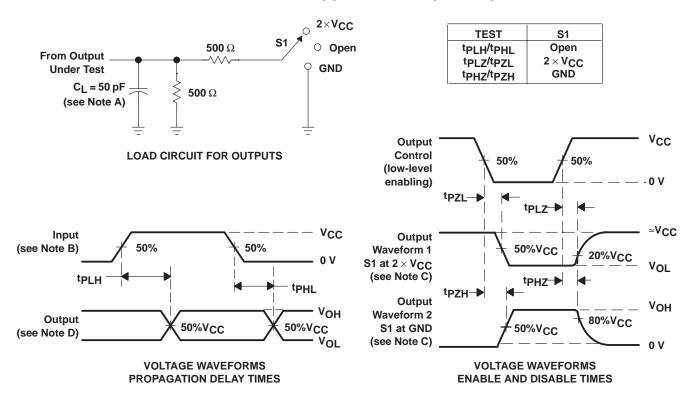
DADAMETED	FROM	то	T _A = 25°C				MAY	
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	UNIT
^t PLH	A or B	B or A	1.5	5.1	7.7	1.5	8.8	ns
^t PHL	AUIB		1.5	4.6	6.9	1.5	7.8	
^t PZH	OE	A or B	1.5	6.5	9.4	1.5	10.6	ns
t _{PZL}	OE	AUID	1.5	6.1	9.4	1.5	10.6	115
^t PHZ	OE	A or B	1.5	6.7	8.6	1.5	9.3	no
^t PLZ] UE	AUID	1.5	7.2	9.1	1.5	9.9	ns

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST C	ONDITIONS	TYP	UNIT	
<u> </u>	Douge dissinction conscitones not transcrive.	Outputs enabled	C. 50 pF	f 4 MALI—	45	
C _{pd}	Power dissipation capacitance per transceiver	Outputs disabled	$C_L = 50 \text{ pF},$	f = 1 MHz	12	pF

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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq 3$ ns, $t_f \leq 3$ ns. For testing pulse duration: $t_r = t_f = 1$ to 3 ns. Pulse polarity can be either high-to-low-to-high or low-to-high-to-low.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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